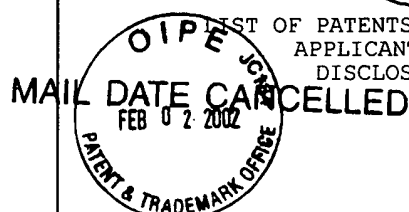
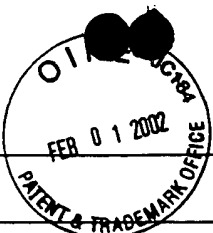


Sheet 1 of 1

FORM PTO-1449

Atty. Docket No.:
P32.12-0006Appl. No.:
09/855,179

LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION
DISCLOSURE STATEMENT

First Named Inventor:

Evren Eryurek et al.

Filing Date

Group Art:

May 14, 2001

2661

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
XS	AA	4,249,164	02/03/81	Tivy	340	870.3
XS	AB	5,469,749	11/28/95	Shimada et al.	73	861.47
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FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No
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DATE CONSIDERED:

08/20/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	Atty. Docket No.: P32.12-0006	Appl. No.: 09/855,179
<p>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</p> 	First Named Inventor:	
	Evren Eryurek et al.	
	Filing Date	Group Art:
	May 14, 2001	2661

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
XS	AA 5,880,376	03/09/99	Sai et al.	73	861.08	
XS	AB 6,038,579	03/14/00	Sekine	708	400	
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FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



FORM PTO-1449	Atty. Docket No.: P32.12-0006	Appl. No.: 09/335,179
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:	
	Evren Eryurek et al.	
	Filing Date	Group Art:
	May 14, 2001	2661

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
XS	AA	3,855,858	12/24/74	Cushing	73	194 EM
↓	AB	5,388,465	02/14/95	Okaniwa et al.	73	861.17
↓	AC	5,560,246	10/01/96	Bottinger et al.	73	861.15
↓	AD	6,014,902	01/18/00	Lewis et al.	73	861.12
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FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Sub Class	Translation Yes No
XS	AL	59163520	09/14/84	Japan	—	—	(Abstract Only)
↓	AM	60174915	09/09/85	Japan	—	—	(Abstract Only)
↓	AN	11083575	03/26/99	Japan	—	—	(Abstract Only)

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

XS	AO	Copy of International Search Report from Application Number PCT/US01/40791 with international filing date of May 22, 2001.
XS	AP	Copy of International Search Report from Application Number PCT/US01/40782 with international filing date of May 22, 2001.
	AQ	


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FORM PTO-1449	Atty. Docket No.: P32.12-0006	Appl. No.: 09/855,179
<p>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</p> 	First Named Inventor:	
	Evren Eryurek et al.	
	Filing Date	Group Art:
	May 14, 2001	2661

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
XS	AA	6,016,523	01/18/00	Zimmerman et al.	710	63
XS	AB	6,052,655	04/18/00	Kobayashi et al.	702	184
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FOREIGN PATENT DOCUMENTS

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